

<b>Notice of References Cited</b>	Application/Control No. 10/733,845	Applicant(s)/Patent Under Reexamination ANDREWS ET AL.	
	Examiner Evan Pert	Art Unit 2829	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,653,210	11-2003	Choo et al.	438/460
	B	US-6,211,488	04-2001	Hoekstra et al.	219/121.72
	C	US-5,543,365	08-1996	Wills et al.	438/462
	D	US-5,185,295	02-1993	Goto et al.	438/463
	E	US-4,355,457	10-1982	Barlett et al.	438/460
	F	US-3,970,819	07-1976	Gates et al.	219/121.69
	G	US-3,816,700	06-1974	Weiner et al.	219/121.68
	H	US-3,626,141	12-1971	Daly, Richard T.	219/121.68
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	J. Han et al., "Blue/Green Lasers Focus on the Market", 1994 IEEE, Circuits and Devices, pages 18-23.
	V	Lizotte, "Laser Dicing of Chip Scale and Silicon Wafer Scale Packages", July 2003, Electronics Manufacturing Technology Symposium, pages 1-5.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.